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Contents of volume 333

Editorial

Ballschmiter K: Fresenius goes English? 1

Review

Belliardo JJ, see Lindsey AS, et al. 559
Braun T: Quasi-spherical solid polymer membranes in separation chemistry: polyurethane foams as sorbents. Recent advances 785
Lindsey AS, Belliardo JJ, Wagstaffe PJ: Utilisation of certified reference materials in monitoring common environmental pollutants (PAHs, Nitro-PAHs, PCBs) 599
Wagstaffe PJ, see Lindsey AS, et al. 599

Original papers

Amin M: Stability studies of a prostaglandin-derivative of the subgroup E_2 in pharmaceutical preparations 134
Arpadjan S, see Karadjova I, et al. 9
Arranz Garcia A, see Arranz Valentin JF, et al. 218
Arranz Valentin JF, Goicolea Altuna A, Barrio Diez-Caballero RJ, Arranz Garcia A: Study of the conditions for the determination of metamitron by differential pulse polarography 218

Ballschmiter K, see Buchert H, et al. 211
Barrio Diez-Caballero RJ, see Arranz Valentin JF, et al. 218
Bächmann K, Blaskowitz K-H: Determination of alkali and alkaline earth elements with indirect fluorescence detection in the pg-range (in German) 15
Beauchemin D, see Berman SS, et al. 641
Berman SS, Siu KWM, Maxwell PS, Beauchemin D, Clancy VP: Marine biological reference materials for methylmercury: analytical methodologies used in certification 641
Blaskowitz K-H, see Bächmann K 15
Brabec T, see Stingeder G, et al. 191
Broekaert JAC, see Leis F, et al. 2
Buchert H, Class T, Ballschmiter K: High resolution gas chromatography of technical chlordane with electron capture- and mass selective detection 211

Chikuma M, see Itoh K, et al. 102
Clancy VP, see Berman SS, et al. 641
Class T, see Buchert H, et al. 211
Clements S, see Schelenz R, et al. 33

Daase M, see Matissek R, et al. 806
Danzer K, see Geiß S, et al. 97
Deligeorgiev T, see Karadjova I, et al. 9
Diaz C, Vidal JC, Galban J, Navas MA, Lanaja J: A double-membrane nitrate ion-selective electrode based on aliquat-nitrate in paraffin 619
Dickert FL, Vonend M, Kimmel H, Mages G: Dyes of the triphenylmethane type as sensor materials for solvent vapours 615
Dransfeld I, Hintsche R, Scheller F: Enzyme electrodes for lactate and maltose using a fluoride ion-sensitive electrode (in German) 23

Einax J, see Geiß S, et al. 97

Fischer P, see Tschäbunin G, et al. 111
Fischer P, see Tschäbunin G, et al. 117
Fischer P, see Tschäbunin G, et al. 123
Fujita K, see Mori I, et al. 42
Fujita Y, see Mori I, et al. 42

Galban J, see Diaz C, et al. 619
Gansen M, see Wünsch G 607
Geiß S, Einax J, Danzer K: Multivariate-statistical examinations of the sampling strategy in the analysis of river water (in German) 97
Goicolea Altuna A, see Arranz Valentin JF, et al. 218
Gruß R, Scheller F: Amperometric method for the determination of the activity of cholinesterases and detection of the inhibitors of the enzymes (in German) 29
Günther K, Umland F: Determination of dimethylthallium ions by means of secondary ion mass spectrometry after extraction (in German) 6

Hahn M, see Spohn U, et al. 39
Hasebe K, Hikima S, Kakizaki T, Yoshida H: Differential pulse polarographic determination of citric acid with a soluble enzyme preparation 19
Hikima S, see Hasebe K, et al. 19
Hintsche R, see Dransfeld I, et al. 23
Holter A, Perkampus H-H: Single-beam PA-spectrometer for investigations of solutions (in German) 629

Itoh K, Chikuma M, Nishimura M, Tanaka T, Tanaka M, Nakayama M, Tanaka H: Determination of selenium(IV) and other forms of selenium dissolved in sea water by anion-exchange resin loaded with sulfonic acid derivative of bismuthiol-II and hydride generation atomic-absorption spectrometry 102

Kakizaki T, see Hasebe K, et al. 19
Karadjova I, Arpadjan S, Deligeorgiev T: On the determination of trace impurities in high-purity lead salts (in German) 9
Kato K, see Mori I, et al. 42
Kimmel H, see Dickert FL, et al. 615
Kuhnert W, see Stingeder G, et al. 191
Kutsch H, Schleich C: Improved colorimetric determination of high-molecular weight hyaluronic acid from synovial fluids 810

Lanaja J, see Diaz C, et al. 619
Leis F, Broekaert JAC, Waechter H: A three-electrode direct current plasma as compared to an inductively coupled argon plasma 2
Levsen K, see Schilhabel J 800

Mages G, see Dickert FL, et al. 615
Mahmoud WH, see Ramadan RM 140
Markert B: Distribution of chemical elements in *Vaccinium myrtillus* (blueberry) – basic problems for representative sampling of plants for multi-element analysis in ecosystems 11
Marzec A, see Wang Xiangming, et al. 793
Matissek R, Nagorka R, Daase M, Wengatz I: Analysis of methylisothiazolones by ion pair high-performance liquid chromatography after pre-column derivatisation. Part II. Determination of 2-methyl-3(2H)-isothiazolone and 5-chloro-2-methyl-3(2H)-isothiazolone in cosmetics 806

Matschiner H, see Spohn U, et al. 39
Matsuo R, see Mori I, et al. 42
Maxwell PS, see Berman SS, et al. 641
Michal J, Mitera J, Novák J: Analysis of the total organic fraction of mine aerosols 221
Mitera J, see Michal J, et al. 221
Mori I, Fujita Y, Fujita K, Nakahashi Y, Matsuo R, Kato K: Fluorescence reaction between o-hydroxyhydroquinonephthalein and vanadium in micellar media, and its application 42

Nagorka R, see Matissek R, et al. 806
Nakahashi Y, see Mori I, et al. 42
Nakamura A, see Shintani H 637
Nakayama M, see Itoh K, et al. 102
Navas MA, see Diaz C, et al. 619
Niessner R, Walendzik G: The photoelectric aerosol sensor as a fast-responding and sensitive detection system for cigarette smoke analysis 129
Nishimura M, see Itoh K, et al. 102
Novák J, see Michal J, et al. 221

Parr RM, see Schelenz R, et al. 33
Perkampus H-H, see Holter A 629
Pongratz P, see Stingeder G, et al. 191

Ramadan RM, Mahmoud WH: Determination of some halogen osmium-carbonyl derivatives using ion-selective electrodes 140
Rohen A, Umland F: Indication of the sulphate precipitation-titration using adsorption-polarized electrodes. Influence of electrode pretreatment and interferences (in German) 35
Rüttinger H-H, see Spohn U, et al. 39

Schelenz R, Parr RM, Zeiller E, Clements S: Chromium in biological materials – IAEA intercomparison results 33
Scheller F, see Dransfeld I, et al. 23
Scheller F, see Gruß R 29
Schilhabel J, Levsen K: Identification of nitrated polycyclic hydrocarbons in diesel particulate extracts by negative ion chemical ionization and tandem mass spectrometry 800
Schleich C, see Kutsch H 810
Schramel P: Determination of some additional trace elements in certified standard reference materials (soils, sludges, sediment) by ICP-emission spectrometry 203
Schulten H-R, see Xiangming W, et al. 793
Schwedt G, see Tschäbunin G, et al. 111, 117, 123
Shen Wangxing, see Yu Liqiang 108
Shintani H, Nakamura A: Analysis of the carcinogen 4,4′-methylenedianiline (MDA) in gamma-ray and in autoclave-sterilized polyurethane 637
Siu KWM, see Berman SS, et al. 641
Spohn U, Hahn M, Rüttinger H-H, Matschiner H: A new measuring device for rapid coulometric Karl-Fischer-titrations 39
Steinwandter H: Simple screening method for the fast determination of clenbuterol in animal feeds 634
Stingeder G, Pongratz P, Kuhnert W, Brabec T: Investigation of high concentration effects of Sb and P in silicon by combination of SIMS and TEM 191

Tanaka H, see Itoh K, et al. 102
Tanaka M, see Itoh K, et al. 102
Tanaka T, see Itoh K, et al. 102
TEGEWA: Determination of monomeric ethylene oxide in pharmaceutical raw materials 26
Tschäbunin G, Fischer P, Schwedt G: On the analysis of polymethylenephosphonic acids. I. A systematic survey of the ion-chromatography of organophosphonic acids (in German) 111
Tschäbunin G, Fischer P, Schwedt G: On the analysis of polymethylenephosphonic acids. II. A systematic survey of post-column derivatization in ion chromatography (in German) 117
Tschäbunin G, Schwedt G, Fischer P: On the analysis of polymethylenephosphonic acids. III. Stability of ethylenediaminetetramethylenephosphonic acid (EDTMP) in aqueous solution (in German) 123

Umland F, see Günther K 2
Umland F, see Rohen A 35

van Staden JF: Preparation and performance of a coated tubular solid-state lead(II)-selective electrode in flow-injection analysis 226
Vidal JC, see Diaz C, et al. 619
Vonend M, see Dickert FL, et al. 615

Waechter H, see Leis F, et al. 2
Walendzik G, see Niessner R 129
Wang Xiangming, Marzec A, Schulten H-R: Coal characterization by on-line pyrolysis-field ionization mass spectrometry 793
Wengatz I, see Matissek R, et al. 806
Wolf S: A universal solvent system for two-phase acid/base titrations (in German) 624
Wünsch G, Gansen M: Applicability and application of expert systems in analytical chemistry (in German) 607

Yoshida H, see Hasebe K, et al. 19
Yu Liqiang, Shen Wangxing: Rapid decomposition method for silicate samples 108

Zeiller E, see Schelenz R, et al. 33

Short communications

Adeberg V, Brügmann L, Doerffel K, Moenke L: Detection of periodicities in a line-scan with high noise by means of correlation functions (in German) 143

Brügmann L, see Adeberg V, et al. 143
Buchbauer G, see Nikiforov A, et al. 46

Doerffel K, see Adeberg V, et al. 143
Düsedau B, see Senf L, et al. 47

Jirovetz L, see Nikiforov A, et al. 46

Moenke L, see Adeberg V, et al. 143

Nikiforov A, Stanek W, Woidich A, Jirovetz L, Buchbauer G: A simple and efficient method of micropreparative gas chromatography with fused silica capillary columns and splitting system (in German) 46

Rechnitz GA, see Zink P 645

Senf L, Stapf F, Düsedau B: Method for the thermal desorption of atmospheric industrial pollutants adsorbed on activated carbon (in German) 47
Stanek W, see Nikiforov A, et al. 46
Stapf F, see Senf L, et al. 47

Woidich A, see Nikiforov A, et al. 46

Zink P, Rechnitz GA: Intact chemoreceptor-based biosensor for pesticides (in German) 645

Letter to the Editor

Bhushan R: Note to Fresenius Z Anal Chem 329: 793 144

Proceedings of the 5th Working Conference on Applied Surface Analysis

Ache HJ, see Kaufmann R, et al. 398
Ache HJ, see Maar-Stumm M, et al. 406
Adrian H, see Peters H, et al. 343
Aïte K, see Keim EG 319
Andersson K, Borchardt G, Scherrer S, Weber S: Self-diffusion in Mg_2SiO_4 (forsterite) at high temperature. A model case study for SIMS analyses on ceramic surfaces 383
Atari A, see Danninger H, et al. 417

Bach H: Problems with the analysis of glass and glass ceramic surfaces and coatings 373
Bange K, see Wagner W, et al. 478
Bartl H: Water of crystallization and its hydrogen-bonded cross-linking in vivianite $Fe_3(PO_4)_2 \cdot 8H_2O$; a neutron diffraction investigation 401
Baumgartl S, Busch P: Quantitative analysis of steel sheet surfaces using computer-aided electron probe microanalysis 441
Benjelloun-Saki N, see Herion J, et al. 531
Benndorf C, see Grischke M, et al. 299
Bensch W, see Pamler W, et al. 569
Berneike W, Knoth J, Schwenke H, Weisbrod U: Surface analysis for Si-wafers using total reflection X-ray fluorescence analysis 524
Berresheim KH, see v. Rosenstiel AP, et al. 535
Besocke K: Scanning tunneling microscopy – a new method in surface analysis 312
Beyer W, see Herion J, et al. 531
Boemcke A, see Koenig W 461
Bolze T, see Mühlhoff L 527
Borchardt G, see Andersson K, et al. 383
Borrell M, see Novacek P, et al. 453
Bradshaw AM, see Horn K, et al. 590
Brandstädter A, Koizlik K, Linke J, Nickel H, Tzartzas I, Wallura E: Quantitative analysis of the structure in the fracture zone of silicon carbide 394
Brauer A, see Grischke M, et al. 299
Braun W, see Schaible M, et al. 335
Bräuer S, Krämer B, Pagnia H, Sotnik N, Vetter K-H, Wirth W: Fast scanning tunneling microscope in constant current mode 340
Bräuer S, Pagnia H, Rücker M, Sotnik N, Wirth W: Potentiometry on MIM-structures with a STM 337
Bremer T, Kollewe D, Koschmieder H, Heiland W: SIMS investigations of titanium profiles in $LiNbO_3$ produced by ion beam mixing and diffusion 485
Bremer T, see Saler J, et al. 426
Bruis WHJ, see v. Rosenstiel AP, et al. 535
Bruns M, see Maar-Stumm M, et al. 406
Bubert H, Puderbach H, Pulm H, Roland WA: Investigations on zirconium-containing conversion layers on aluminium 304
Bubert H, see Jenett H, et al. 502
Bubert H, see Schönborn A, et al. 511
Busch P, see Baumgartl S 441
Bußmann E, see Pamler W, et al. 569

Casel A, Sasse E, Kibbel H: B-contamination of Si-surfaces 522
Crecelius G, see Peters H, et al. 343

Danninger H, Atari A, Lux B, Kny E, Tschulik A: Embrittlement of tungsten heavy alloys by trace impurities and their analytical characterization 417
Däumer B, see Niessner R, et al. 437
de Rugy H, Saliot P, Pantel R: Quantification of Auger depth profiles by means of Rutherford backscattering spectrometry 331
Doblhofer K, see Horn K, et al. 590
Dongfeng Pan, see Müller U, et al. 433
Dudek HJ: Interface analysis in metal matrix composites 422

Esser HG, see Friedbacher G, et al. 413

Fischer J, Kong Q, Stehlin T, Träger F: Study of transient thermal surface processes 350
Frenzel H, see Maul JL 318
Friedbacher G, see Schönborn A, et al. 511
Friedbacher G, Virag A, Grasserbauer M, Esser HG, Wienhold P: SIMS investigations of wall coatings for application in nuclear fusion reactors 413

Gara S, see Stingeder G, et al. 576
Gast T, see Robens E, et al. 428
Gauglitz G, Krause-Bonte J: Dynamic examinations at photoresists by reflectance spectroscopy 518
Gerstenberg KW, Taube K: Measurement of the Young's modulus for structural characterization of amorphous Si:C:N:H-films 313
Gimmel P, Gompf B, Schmeißer D, Göpel W: Depth profiles of $Ta_2O_5/SiO_2/Si$ structures: a combined X-ray photoemission, Auger electron, and secondary ion mass spectroscopic study 466
Gnaser H: In situ ion implantation for quantification in secondary-ion mass spectrometry 507
Gompf B, see Gimmel P, et al. 466
Goretzki H, v. Rosenstiel AP, Mandziej S: Small area MXPS- and TEM-measurements on temper-embrittled 12% Cr steel 451
Göpel W, see Gimmel P, et al. 466
Grallath E, see Jenett H, et al. 502
Grasserbauer M, see Friedbacher G, et al. 413
Grasserbauer M, see Schönborn A, et al. 511
Grasserbauer M, see Schreiner M, et al. 386
Grasserbauer M, see Stingeder G, et al. 576
Grathwohl G, see Meier B 388
Gries WH: Surface analysis within the framework of the International Union of Pure and Applied Chemistry 596
Grillet Y, see Müller U, et al. 433
Grischke M, Brauer A, Benndorf C, Thieme F, Willich P: Quantitative XPS-analysis of tantalum-containing amorphous carbon films 299
Grunenberg D, see Koch KH, et al. 447
Guerrero E, see Stingeder G, et al. 576
Gütlich P, see Meisel W, et al. 555

Habig K-H: Surface analysis problems in tribology 456
Heiland W, see Bremer T, et al. 485
Herion J, Tapiero M, Zielinger JP, Benjelloun-Saki N, Beyer W: Investigation of deep states in thin films of hydrogenated amorphous silicon by photo-induced current transient spectroscopy 531
Hofer W, see Novacek P, et al. 453
Hofmann S, see Steffen J 408
Hoinkis E, see Robens E, et al. 428
Holleck H, see Nold E, et al. 492
Holm R, Holtkamp D, Kleinstück R, Rother H-J, Storp S: Surface analysis methods in the investigation of corrosion inhibitor performance 546
Holtkamp D, see Holm R, et al. 546
Horn K, Bradshaw AM, Doblhofer K, Krause S, Weinberg G, Seidenspinner H-M, Schulz R: A study of the adhesion of copper to polyimide foils using surface analytical techniques 590
Hösler W: On sample topography and its influence on the spatial resolution of Scanning Auger Microscopy 315
Hub W, see Penka V 586

Jenett H, Bubert H, Grallath E: Comparative surface and bulk analysis of oxygen in Si_3N_4 powders 502

Kaufmann R, Klewe-Nebenius H, Pfennig G, Ache HJ: XPS and AES investigations of the reaction behaviour of iodine with Zircaloy-4 surfaces 398
Keim EG, Aïte K: Quantitative Auger depth profiling of LPCVD and PECVD silicon nitride films 319
Kibbel H, see Casel A, et al. 522
Kleinstück R, see Holm R, et al. 546
Klewe-Nebenius H, see Kaufmann R, et al. 398
Klewe-Nebenius H, see Maar-Stumm M, et al. 406
Klockow D, see Niessner R, et al. 437
Knoth J, see Berneike W, et al. 524
Kny E, see Danninger H, et al. 417
Koch E-E, see Schaible M, et al. 335
Koch KH, Sommer D, Grunenberg D: Quantification of SNMS investigations of coated materials 447
Koeiman OA, see v. Rosenstiel AP, et al. 535
Koenig W, Boemcke A: Wear mechanisms of ultra-hard non-metallic cutting materials 461
Kohlhof K, Mantl S, Stritzker B: Ion channeling analysis of buried epitaxial Co silicides 583
Koizlik K, see Brandstädter A, et al. 394
Kolbesen BO, Pamler W: Surface and thin film analysis in silicon technology: actual and future problems and demands 561
Kollewe D, see Bremer T, et al. 485
Kong Q, see Fischer J, et al. 350
Koschmieder H, see Bremer T, et al. 485
Koschmieder H, see Saler J, et al. 426
Krause-Bonte J, see Gauglitz G 518
Krause S, see Horn K, et al. 590
Krämer B, see Bräuer S, et al. 340

Le Goux JJ, see Migeon HN, et al. 333
Leiste H, see Nold E, et al. 492
Liegl A, see Novacek P, et al. 453
Lindner JKN, see Schönborn A, et al. 511
Lindner U, Papp H: XPS and ISS analysis of Fischer-Tropsch catalysts 540
Linke J, see Brandstädter A, et al. 394
Lugscheider E, Weber T: Coating technology. Objectives, potentiality and contribution of analytical techniques in the case of plasma spraying 293
Lux B, see Danninger H, et al. 417

Maar-Stumm M, Bruns M, Klewe-Nebenius H, Ache HJ: Corrosion behaviour of the steel 1.4361 studied by combined XPS, electrochemistry and radionuclide techniques 406
Maier M, see Roß D 488
Malissa H: Philosophical aspects on analytical chemistry 285
Mandziej S, see Goretzki H, et al. 451
Mantl S, see Kohlhof K, et al. 583
March P, see Schreiner M, et al. 386
Maul JL, Frenzel H: SIMS depth profiling using new gate techniques 318
Meier B, Grathwohl G: Microanalytical investigation of fibre-reinforced ceramic materials 388
Meisel W, Stumm U, Gütlich P: A CEMS/AES study of the passivation of iron 555
Mersmann A, see Müller U, et al. 433
Mertens PR, see v. Rosenstiel AP, et al. 535
Miethe K: Ion fractions of matrix elements and impurities in GaAs bombarded by O_2^+ primary ions 322
Migeon HN, Schuhmacher M, Le Goux JJ, Rasser B: Three-dimensional analysis of trace elements with the CAMECA IMS 4F 333
Mitwalsky A, see Pamler W, et al. 569
Mühlhoff L, Bolze T: Surface analytical characterization of oxide-free Si(100) wafer surfaces 527
Müller A, see v. Czarnecki J, et al. 346
Müller K-H, Rupertus V, Oechsner H, Scheuer V, Tschudi T: Analysis of sputter deposited and evaporated tantalum oxide layers on SiO_2 by SNMS, XPS, TDS and TRFA 498
Müller U, Reichert H, Robens E, Unger KK, Grillet Y, Rouquerol F, Rouquerol J, Dongfeng Pan, Mersmann A: High-resolution sorption studies of argon and nitrogen on large crystals of microporous zeolite ZSM-5 433
Müller U, see Robens E, et al. 428

Nickel H: Editorial 283
Nickel H, see Brandstädter A, et al. 394
Niessner R, Däumer B, Klockow D: Investigations on the surface properties of ultrafine aerosols by means of a multistep condensation nuclei counter 437
Niessner R, Wilbring P: Determination of the sorption- and desorption-properties from PAH-coated ultrafine particles with the photoelectric aerosol sensor 439
Nold E, Holleck H, Leiste H: High-resolution Auger electron spectroscopy of phase boundaries in TiC/TiB_2 materials 492
Novacek P, Liegl A, Vonbank M, Borrell M, Hofer W, Varga P: Determination of the surface segregation of alloys 453

Oechsner H, see Müller K-H, et al. 498
Oechsner H, see Scholtes J 474
Oechsner H, see Wucher A 470
Oelichmann J: Surface and depth-profile analysis using FTIR spectroscopy 353

Pagnia H, see Bräuer S, et al. 337, 340
Pahlke S, see Stingeder G, et al. 576
Pamler W, see Kolbesen BO 561
Pamler W, Wangemann K, Bensch W, Bußmann E, Mitwalsky A: Kinetics of titanium silicide formation by rapid thermal processing 569
Pantel R, see de Rugy H, et al. 331
Papp H, see Lindner U 540
Penka V, Hub W: Detection of metallic trace impurities on Si(100) surfaces with total reflection X-ray fluorescence (TXRF) 586
Petersen H, see Schaible M, et al. 335
Peters H, Skoda L, Crecelius G, Adrian H: Quantitative depth profile analysis of high-T_c-superconductors with sputtered neutral mass spectrometry (SNMS) 343
Pfennig G, see Kaufmann R, et al. 398
Piplits K, see Schreiner M, et al. 386
Puderbach H, see Bubert H, et al. 304
Pulm H, see Bubert H, et al. 304

Rasser B, see Migeon HN, et al. 333
Rauch F, see Schreiner M, et al. 386
Rauch F, see Wagner W, et al. 478
Reichelt K, see Schmidt K, et al. 326
Reichert H, see Müller U, et al. 433
Reim W, see Weller D 481
Riahi A, see Tschulik A, et al. 404
Rist O, see v. Czarnecki J, et al. 346
Robens E, Gast T, Hoinkis E, Müller U: Surface area, density and porosity measurements using the magnetic suspension balance 428
Robens E, see Müller U, et al. 433
Roland WA, see Bubert H, et al. 304
Roß D, Maier M: Thickness measurement of thin dielectrics with electron spectroscopy 488
Rother H-J, see Holm R, et al. 546
Rouquerol F, see Müller U, et al. 433
Rouquerol J, see Müller U, et al. 433
Rupertus V, see Müller K-H, et al. 498
Rücker M, see Bräuer S, et al. 337
Rüdenauer FG: Multidimensional image acquisition and processing in surface analysis 308

Saler J, Bremer T, Koschmieder H: A study of photographic paper by secondary-ion-mass-spectrometry 426
Saliot P, see de Rugy H, et al. 331
Sasse E, see Casel A, et al. 522
Schaefer JA: Characterization of semiconductor surfaces 516

Schaible M, Braun W, Petersen H, Koch E-E: High lateral resolution and very high sensitivity in XPS with excitation by Synchrotron radiation 335
Scherrer S, see Andersson K, et al. 383
Scheuer V, see Müller K-H, et al. 498
Schmeißer D, see Gimmel P, et al. 466
Schmidt K, Reichelt K, Stritzker B, Zou J: Hydrogen profile analysis in a-C:H films by elastic recoil detection (ERD) 326
Schmidt R, Wißmann P: Ellipsometrical measurements on porous copper films 410
Scholtes J, Oechsner H: On the role of ion bombardment parameters in AES sputter depth profiling of Ta_2O_5/Ta with Ar^+ and Xe^+ 474
Schönborn A, Lindner JKN, te Kaat EH, Bubert H, Grasserbauer M, Friedbacher G: AES and SIMS profiling of buried silicide layers formed by 6 MeV high dose nickel implantation into silicon 511
Schreiner M, Piplits K, March P, Stingeder G, Rauch F, Grasserbauer M: Surface analytical investigations of leached potash-lime-silica glass 386
Schuhmacher M, see Migeon HN, et al. 333
Schulz R, see Horn K, et al. 590
Schwenke H, see Berneike W, et al. 524
Schwenk H, see Stingeder G, et al. 576
Seidenspinner H-M, see Horn K, et al. 590
Skoda L, see Peters H, et al. 343
Sommer D, see Koch KH, et al. 447
Sotnik N, see Bräuer S, et al. 337, 340
Steffen J, Hofmann S: Quantitative depth profiling with AES: application to oxide layers of NiCrFe alloys 408
Stehlin T, see Fischer J, et al. 350
Stingeder G, Gara S, Pahlke S, Schwenk H, Guerrero E, Grasserbauer M: Quantitative determination of oxygen in silicon by combination of FTIR-spectroscopy, inert gas fusion analysis and secondary ion mass spectroscopy 576
Stingeder G, see Schreiner M, et al. 386
Storp S, see Holm R, et al. 546
Störi H, see Tschulik A, et al. 404
Stratmann M, see Volmer M, et al. 545
Stritzker B, see Kohlhof K, et al. 583
Stritzker B, see Schmidt K, et al. 326
Stumm U, see Meisel W, et al. 555

Tapiero M, see Herion J, et al. 531
Taube K, see Gerstenberg KW 313
te Kaat EH, see Schönborn A, et al. 511
Thieme F, see Grischke M, et al. 299
Träger F, see Fischer J, et al. 350
Tschudi T, see Müller K-H, et al. 498
Tschulik A, Riahi A, Störi H: Scanning Auger investigation of sulphur and carbon segregation on a steel surface 404
Tschulik A, see Danninger H, et al. 417
Tzartzas I, see Brandstädter A, et al. 394

Unger KK, see Müller U, et al. 433

van Os GH, see v. Rosenstiel AP, et al. 535
Varga P, see Novacek P, et al. 453
v. Czarnecki J, Müller A, Rist O: Acoustic microscopy and XPS-analysis of the polymer/metal-interface of adhesive joints and coatings 346
Vetter K-H, see Bräuer S, et al. 340
Viefhaus H: Chemical and matrix effects in Auger electron spectroscopy 329
Viefhaus H, see Volmer M, et al. 545
Virag A, see Friedbacher G, et al. 413
Volmer M, Stratmann M, Viefhaus H: Interaction between S-organic compounds and iron surfaces 545
Vonbank M, see Novacek P, et al. 453
v. Rosenstiel AP, Bruis WHJ, van Os GH, Mertens PR, Koeiman OA, Berresheim KH: ESCA, SIMS, SEM and XRD investigations of Pt-10%Rh catalyst-gauzes 535
v. Rosenstiel AP, see Goretzki H, et al. 451

Wagner W, Rauch F, Bange K: Concentration profiles of hydrogen in technical oxidic thin films and multilayer systems 478
Wallura E, see Brandstädter A, et al. 394
Wangemann K, see Pamler W, et al. 569
Weber S, see Andersson K, et al. 383
Weber T, see Lugscheider E 293
Weinberg G, see Horn K, et al. 590
Weisbrod U, see Berneike W, et al. 524
Weller D, Reim W: Optical and electron spectroscopy of magneto-optical storage films 481
Wienhold P, see Friedbacher G, et al. 413
Wilbring P, see Niessner R 439
Willich P, see Grischke M, et al. 299
Wirth W, see Bräuer S, et al. 337, 340
Wißmann P, see Schmidt R 410
Wucher A, Oechsner H: Depth scale calibration during sputter removal of multilayer systems by SNMS 470

Ziegler G: Analytical problems with ceramic materials 360
Zielinger JP, see Herion J, et al. 531
Zou J, see Schmidt K, et al. 326

Plenary lectures

Asshauer J: Quantitative chromatography: demand and reality 727

Bayer E: Separation of enantiomers by gas chromatography (in German) 730

Class TJ: Occurrence and global distribution of C_1/C_2-halocarbons 700

Escher C: Polarizing microscopy: classical applications and more recent developments with regard to liquid crystal investigation 757

Gruehn R: High resolution transmission electron microscopy (HRTEM) 781

Hartmann E: Capability of analytical methods for determination 703
Helas G: Organic acids in clean atmospheres 700
Herres W: Capillary gas chromatography – Fourier transform infrared spectroscopy: theory and applications 754

Korte EH: Compatibility of chromatography and molecular spectroscopy 753
Krivan V: Trace element analysis of the multiple phase system air 697

Leis F: Coupled methods in analytical atomic spectroscopy 755
Lengeler B: Applications of synchrotron radiation in surface analysis 781
Levsen K: Coupling of high-performance liquid chromatography with mass spectrometry 754
Lindner W: Liquid chromatographic separation of enantiomers 730

Niemax K: Doppler-free techniques in analytical spectroscopy 702

Perner D: Significance and measurement of atmospheric OH radicals (in German) 699

Regnier FE: High-performance liquid chromatography (HPLC) of proteins 728
Rehme H: Modern analytical techniques and current applications in microelectronics 782
Righetti PG: Isoelectric focusing in immobilized pH-gradients as a probe of protein surface charge 728

Schlögl R: Electron spectroscopy applied to heterogeneous catalysis 783
Siesler HW: Near-infrared spectroscopy: why are still so many analysts opposed to it? 756

Talsky G: Theoretical and practical aspects in higher-order derivative spectrophotometry (in German) 702

Wagner H: Carrier-free electrophoresis for the separation and purification of biopolymers (in German) 729

Posters

Ache HJ, see Bertram-Berg A, et al. 766
Andersson JT, see Schmid B 765

Bacher R, Ballschmiter K: Adsorption liquid chromatography of PCDD and PCDF on the polyphenol-phase: unique structural effects 732
Backes U, Bibernell U, Neidhart B: Air sampling procedure for tetraalkyllead compounds 706
Bächmann K, Bauer H, Schmied W: Determination of aldehydes and carboxylic acids in atmospheric samples 715
Bächmann K, Blaskowitz K-H, Pohl S: Chromatographic determination of cations in atmospheric samples 704
Bächmann K, Bukatsch H, Polzer J, Scharf J: Determination of decomposition products of chlorinated hydrocarbons 714
Bächmann K, see Lohleit M 717
Ballschmiter K, see Bacher R 732
Ballschmiter K, see Boenke A 723
Ballschmiter K, see Braunmiller I 764
Ballschmiter K, see Buchert H, et al. 712
Ballschmiter K, see Ehmann J, et al. 722
Ballschmiter K, see Fischer R 731
Ballschmiter K, see Riehle U 744
Ballschmiter K, see Schimmel H 735
Ballschmiter K, see Schmid B 765
Barth P, Krivan V: Atomization behavior of selenium in the hydride generation AAS by addition of different gases 779
Bauer H, Ebner B, Wolf B: Fully automated high performance capillary zone electrophoresis 751
Bauer H, see Bächmann K, et al. 715
Baumeister W, Zens B, Vierle O: Simplified clean-up procedure for the PAH profile analysis of suspended particulate matter, diesel engine exhaust, and soil extracts by use of commercial solid phase extraction columns 710
Bayer E, see Geckeler KE, et al. 763
Bertram-Berg A, Mainka E, Ache HJ: Determination of gadolinium in aqueous solutions by time-resolved fluorimetry 766
Bibernell U, see Backes U, et al. 706
Bittner J, see Hammes W, et al. 745
Blaskowitz K-H, see Bächmann K, et al. 704
Boenke A, Ballschmiter K: Formation of polychlorinated dibenzofurans in the pyrolysis of chlorinated fluorenones and 9,10-anthraquinones at 400°C 723
Boos K-S, Wilmers B, Lintelmann J, Sauerbrey R: Bioanalytical dual-column HPLC-systems 739
Braunmiller I, Ballschmiter K: HPLC-separation and fluorimetric detection of chlorinated aromatic acids after pre-column derivatization with 9-bromomethylanthracene 764

Brückner H, Nuber K, Reinecke C: Chromatographic detection of bioactive Aib-peptides in molds of the genus *Stilbella* 777
Brückner H, Wittner R, Hausch M, Godel H: Chiral amino acid analysis in fermented foods using *o*-phthaldialdehyde and novel *N*-acyl-L-cysteines 775
Buchert H, Krämer W, Ballschmiter K: The pattern of polychlorobiphenyls (PCB) in the water column of the North Atlantic 712
Bukatsch H, see Bächmann K, et al. 714

Casida JE, see Class TJ 743
Christmann W, Klöppel KD, Knoth W, Partscht H, Rotard W: Polychlorinated dibenzodioxins/-furans, phenols and lindan in indoors, treated with pentachlorophenol containing wood preserving materials 724
Class TJ, Casida JE: HRGC-MS studies on the microsomal oxidase metabolites of the pyrethroid insecticide S-bioallethrin 743

Dunemann L, Reinecke H: Changes of the distribution patterns of metals in chromatographic processes after spiking of samples 737
Dürbeck HW, see Prast H, et al. 709

Ebner B, see Bauer H, et al. 751
Ehmann J, Zoller W, Ballschmiter K: Degradation products of the PCB-substitute tetrachlorobenzyltoluene (TCBT) by reaction with hydrogen peroxide at 400°C 722
Elsholz O, see Schulze G 740
Engelhardt H, see Frank D 720
Engelhardt H, see Meyer E 734
Engelhardt H, see Schöndorf G 719

Fischer R, Ballschmiter K: Relationship between experimentally determined vapour pressures and retention times of PCB on a 50% n-octyl-methylpolysiloxane stationary phase 731
Frank D, Engelhardt H: Separation and determination of phenolic compounds in waste water by RP-chromatography 720
Frank H, Vital J, Frank W: Oxidation of airborne C_2-chlorocarbons to trichloroacetic and dichloroacetic acid 713
Frank W, see Frank H, et al. 713
Fuchs P: Fast analysis of Ar, O_2, CH_4, CO and CO_2 with capillary gas chromatography 738

Geckeler KE, Bayer E, Shkinev VM, Spivakov BY: Determination of trace elements by flame atomic absorption spectrometry after preconcentration by liquid-phase polymer-based retention (LPR) 763
Gerwert K, Hess B: Intramolecular protein reactions investigated by time-resolved FTIR difference spectroscopy 778
Godel H, see Brückner H, et al. 775
Görtz H, see Rau A 758

Hahn L, see Wendl W, et al. 763
Hammes W, Bittner J, Müller RF: Simultaneous determination of nicotine and cotinine in plasma by capillary gas liquid chromatography with nitrogen-sensitive detection 745
Han E, see Schulze G 769
Hausch M, see Brückner H, et al. 775
Hein M, Hoffmann P, Lieser KH: Application of X-ray fluorescence with total-reflection sample carrier in the analysis of small atmospheric samples 718
Hemmerich B, see Niessner R, et al. 704
Hess B, see Gerwert K 778
Hoeppener-Kramar U, Mainka E: Determination of uranium in nitric acid solution by time resolved fluorimetry 760
Hoffmann P, see Hein M, et al. 718
Hoffmann P, see Weidenauer M, et al. 749
Hofmann H, see Weidenauer M, et al. 749
Hollmann D, see Schuster M, et al. 780
Huffer M, Schreier P: Analytical resolution of 4(5)-alkylated $\gamma(\delta)$-lactones by HPLC on silica-bonded chiral polyacrylamide-sorbent 736

Jacob E: Inorganic multielemental analysis by fluorine volatilization systems (FV/FTIR and FV/MS) 761
Jin Zilin, see Zhao Guoliang, et al. 741

Kintrup L, see Puderbach H, et al. 768
Klapper A: Determination of dye concentration in mixtures using single strand fiber optic spectrophotometry and an ATR probe 762
Kleine TO: Adaptation of leucocyte and erythrocyte countings of a hematology analyzer to low cell contents of cerebrospinal fluid (CSF) samples 772
Kleine TO: An approach to quantify tricyclic antidepressants serum levels by the enzyme multiplied immunoassay technique (EMIT) in the Du Pont aca-SX discrete clinical analyzer 774
Klöppel KD, see Christmann W, et al. 724
Knoth W, see Christmann W, et al. 724
Kochen W, see Röper J 747
Koppenhoefer B, Trettin U: Is it possible to affect the enantiomeric composition by a simple distillation process? 750
König K-H, see Schuster M, et al. 780
Krämer W, see Buchert H, et al. 712
Krivan V, Schäfer F: Surface deposits on spruce needles as a possible indicator for the degree of heavy metal pollution of the atmosphere 726
Krivan V, see Barth P 779
Krupp A, see Niessner R, et al. 708
Kübler A, see Weidenauer M, et al. 749

Lehmann C, Lorber K-E, Ruthenberg K, Schulze G: Heavy metal status of the Plötzensee in Berlin – Comparison of solid sample determination and measurement after digestion with Zeeman atomic absorption spectrometry 707
Levsen K, see Schilhabel J, et al. 748
Levsen K, see Winkeler HD 716
Lieser KH, see Hein M, et al. 718
Lieser KH, see Weidenauer M, et al. 749
Lintelmann J, see Boos K-S, et al. 739
Liu Zhiguang, see Zhao Guoliang, et al. 741
Lohleit M, Bächmann K: Potential of supercritical fluid chromatography and supercritical fluid extraction in atmospheric chemistry 717
Lorber K-E, see Lehmann C, et al. 707

Mainka E, see Bertram-Berg A, et al. 766
Mainka E, see Hoeppener-Kramar U 760
Meyer E, Engelhardt H: Influence of residual silanol groups on the separation and asymmetry of basic compounds in RP-HPLC 734
Mitura H: A collecting and analysing system for the determination of chlorinated hydrocarbons in working place atmospheres 711
Müller RF, see Hammes W, et al. 745
Müller-Vogt G, see Wendl W, et al. 763

Narres HD, see Prast H, et al. 709
Neidhart B, see Backes U, et al. 706
Niehaus R, see Prast H, et al. 709
Niessner R, Hemmerich B, Panne U: The photoelectric aerosol sensor array as instrument for the "on line"-detection of heavy metal aerosols 704
Niessner R, Robers W, Krupp A: A new analytical concept: remote laser-induced and time-resolved fluorescence (LIF) of PAH's in aerosols or water 708
Nuber K, see Brückner H, et al. 777

Panne U, see Niessner R, et al. 704
Partscht H, see Christmann W, et al. 724
Pohl S, see Bächmann K, et al. 704
Polzer J, see Bächmann K, et al. 714
Prast H, Niehaus R, Scheulen B, Narres HD, Dürbeck HW: A new concept for the determination of PAH in air and in rain water 709
Puderbach H, Pulm H, Kintrup L: Analytical methods for the development and monitoring of catalysts 768
Pulm H, see Puderbach H, et al. 768

Rau A, Görtz H: Optimization in headspace GC/FTIR 758
Reinecke C, see Brückner H, et al. 777
Reinecke H, see Dunemann L 737
Riehle U, Ballschmiter K: Improved congener-specific separation of 2,3,7,8-type polychlorodibenzodioxins (PCDD) and -dibenzofurans (PCDF) by column coupling in gas chromatography 744
Robers W, see Niessner R, et al. 708
Rotard W, see Christmann W, et al. 724
Röper J, Kochen W: Detection of volatile hydrocarbons in human breath by megabore capillary gas chromatography in the low ppb range 747
Ruthenberg K, see Lehmann C, et al. 707

Sauerbrey R, see Boos K-S, et al. 739
Scharf J, see Bächmann K, et al. 714
Schäfer F, see Krivan V 726
Scheulen B, see Prast H, et al. 709
Schierl R: Determination of Pb(II) in soil solutions by voltammetry 769
Schilhabel J, Winkeler HD, Levsen K: Analysis of polycyclic aromatic hydrocarbons in diesel particulate extracts by high performance liquid chromatography (HPLC) 748
Schimmel H, Ballschmiter K: The influence of different substituents on the chemical and chromatographic behaviour of metal 1,2-diketo-bis-(thiosemicarbazones) 735
Schmid B, Andersson JT, Ballschmiter K: Sulfur selective detection in gas chromatography with a microwave-induced plasma detector 765
Schmidtke I, see Weidenauer M, et al. 749
Schmied W, see Bächmann K, et al. 715
Schöndorf G, Engelhardt H: Determination of cyanide in waste water by flow-injection analysis 719
Schreier P, see Huffer M 736
Schulze G, Elsholz O: On-line break-through test for ion-exchange micro-columns using flow injection potentiometric stripping analysis 740
Schulze G, Han E: Potentiometric stripping analysis with a rotating disc electrode in a flow system 769
Schulze G, see Lehmann C, et al. 707
Schulz J: Analysis of oxygenated compounds in motor gasoline by HRGC/FTIR/MS 759
Schuster M, Hollmann D, König K-H: On the analysis of platinum group metals 780
Seil J, v. d. Lieth CW: Application of fuzzy set theory to ^{13}C NMR library searches 767
Seubert A, see Wünsch G 771
Shkinev VM, see Geckeler KE, et al. 763
Spivakov BY, see Geckeler KE, et al. 763

Trettin U, see Koppenhoefer B 750

v. d. Lieth CW, see Seil J 767
Vierle O, see Baumeister W, et al. 710
Vital J, see Frank H, et al. 713

Weidenauer M, Schmidtke I, Kübler A, Hofmann H, Hoffmann P, Lieser KH: Application of ion chromatography for speciation analysis in natural water samples 749
Wendl W, Müller-Vogt G, Hahn L: Investigations of chemical reactions of oxide forming elements in the graphite furnace AAS 763
Wilken J: Eluent-synergism in thin-layer chromatography (in German) 742
Wilmers B, see Boos K-S, et al. 739
Winkeler HD, Levsen K: Low molecular weight organic acids in rain water 716

Winkeler HD, see Schilhabel J, et al. 748
Wittner R, see Brückner H, et al. 775
Wolf B, see Bauer H, et al. 751
Wünsch G, Seubert A: Reaction mechanisms in modern Karl-Fischer-reagents 771
Zens B, see Baumeister W, et al. 710
Zhao Guoliang, Liu Zhiguang, Jin Zilin: Influence of sample concentration on the elution of monocarboxylic acids in ion-exclusion chromatography 741
Zoller W, see Ehmann J, et al. 722

New books 231, 647

Abstracts

1 General analytical chemistry

1.1 Fundamentals, methods, apparatus, reagents, automation, data processing 49, 145, 234, 649

1.2 Inorganic analysis (Elements, isotopes, ions, complex compounds) 59, 155, 243, 658

1.3 Organic analysis (Elements, functional groups, compounds, structural analysis) 65, 160, 247

2 Particular products and fields of application

2.1 Inorganic industrial products (Metals, reactor materials, salts, oxides, semiconductors, glass ceramics, builing materials, industrial solutions etc.) 164, 663

2.2 Organic industrial products (Coal, petroleum, petrochemical products, plastic, textiles, dyes, detergents, intermediate products, paper, leather, rubber etc.) 68, 252, 666

2.3 Geological materials (Rocks, minerals, soils) 72, 670

2.4 Environmental matrices (Air, gases, waste gases, water, waste water, solid wastes etc.) 75, 255, 671

2.5 Agricultural-technical products (Fertilizers, plants, feeding-stuffs, wood etc.) 168, 261

2.6 Foods (Cereals, root crops, oil seeds, fruits, vegetables, animal products, spices, additives, beverages etc.; tobacco and tobacco products) 79, 171, 263, 676

2.7 Pesticides 175

2.8 Pharmaceuticals and cosmetics 265, 680

3 Biochemical and clinical analysis (General, elements, simple body substances, amino-acids, peptides, proteins, nucleic acids, lipids, steroids, hormones, enzymes etc.; drugs, toxic substances) 83, 178, 270, 684

Author index 819

Subject index 832

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